Search	Notes



Application/Control		Applicant(s)/Patent under Reexamination	
10/031,340	LAUPER E	LAUPER ET AL.	
Examiner	Art Unit		
Sheela C. Chawan	2625		

SEARCHED			
Class	Subclass	Date	Examiner
382	117	6/28/2005	scc
382	190, 305	6/28/2005	scc
382	324	6/28/2005	scc
707	10,103R	6/28/2005	scc
713	186	6/28/2005	scc
ABOVE	UPDATE	6/28/2005	scc
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
382	117, 190,	6/28/2005	scc
382	305,324	6/28/2005	scc
707	10, 103R	6/28/2005	scc
713.	/186	6/28/2005	scc

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
382/117, (US. patents only)	6/28/2005	scc
707/10, 103 R (US.patents only)	6/28/2005	scc
EAST, US-PG-PUB, USPAT,EPO, JPO., DERWENT, IBM-TDB. UP-DATE EAST SEARCH.	6/28/2005	scc
CONSULTED SAMIR AHMED, AU 2623.	6/28/2005	scc
INTERFERENCE SEARCH , SEE HISTORY PRINT OUT.	6/28/2005	scc ,